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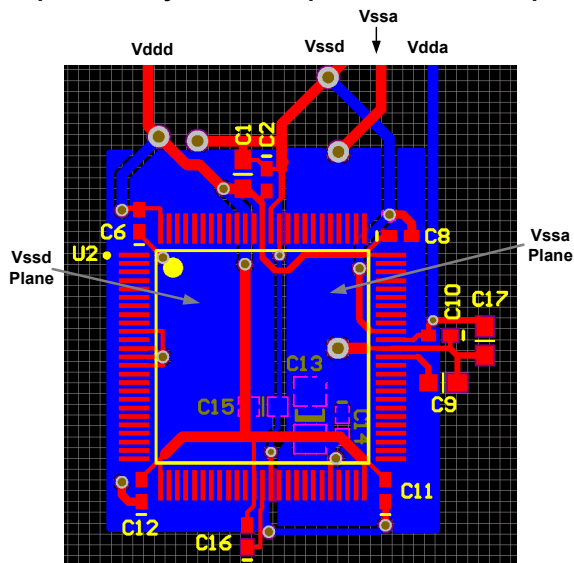
"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "[Embedded - Microcontrollers](#)"

Details

| | |
|----------------------------|---|
| Product Status | Obsolete |
| Core Processor | 8051 |
| Core Size | 8-Bit |
| Speed | 67MHz |
| Connectivity | EBI/EMI, I ² C, LINbus, SPI, UART/USART, USB |
| Peripherals | CapSense, DMA, POR, PWM, WDT |
| Number of I/O | 62 |
| Program Memory Size | 32KB (32K x 8) |
| Program Memory Type | FLASH |
| EEPROM Size | 1K x 8 |
| RAM Size | 4K x 8 |
| Voltage - Supply (Vcc/Vdd) | 1.71V ~ 5.5V |
| Data Converters | A/D 16x20b; D/A 4x8b |
| Oscillator Type | Internal |
| Operating Temperature | -40°C ~ 85°C (TA) |
| Mounting Type | Surface Mount |
| Package / Case | 100-LQFP |
| Supplier Device Package | 100-TQFP (14x14) |
| Purchase URL | https://www.e-xfl.com/product-detail/infineon-technologies/cy8c3865axi-015 |

Figure 2-6. Example PCB Layout for 100-pin TQFP Part for Optimal Analog Performance



3. Pin Descriptions

IDAC0, IDAC1, IDAC2, IDAC3

Low resistance output pin for high current DACs (IDAC).

OpAmp0out, OpAmp1out, OpAmp2out, OpAmp3out

High current output of uncommitted opamp^[12].

Extref0, Extref1

External reference input to the analog system.

OpAmp0-, OpAmp1-, OpAmp2-, OpAmp3-

Inverting input to uncommitted opamp.

OpAmp0+, OpAmp1+, OpAmp2+, OpAmp3+

Noninverting input to uncommitted opamp.

GPIO

General purpose I/O pin provides interfaces to the CPU, digital peripherals, analog peripherals, interrupts, LCD segment drive, and CapSense^[12].

I2C0: SCL, I2C1: SCL

I²C SCL line providing wake from sleep on an address match. Any I/O pin can be used for I²C SCL if wake from sleep is not required.

I2C0: SDA, I2C1: SDA

I²C SDA line providing wake from sleep on an address match. Any I/O pin can be used for I²C SDA if wake from sleep is not required.

Ind

Inductor connection to boost pump.

kHz XTAL: Xo, kHz XTAL: Xi

32.768-kHz crystal oscillator pin.

MHz XTAL: Xo, MHz XTAL: Xi

4- to 33-MHz crystal oscillator pin.

nTRST

Optional JTAG test reset programming and debug port connection to reset the JTAG connection.

SIO

Special I/O provides interfaces to the CPU, digital peripherals and interrupts with a programmable high threshold voltage, analog comparator, high sink current, and high impedance state when the device is unpowered.

SWDCK

Serial wire debug clock programming and debug port connection.

SWDIO

Serial wire debug input and output programming and debug port connection.

SWV.

Single wire viewer debug output.

TCK

JTAG test clock programming and debug port connection.

TDI

JTAG test data in programming and debug port connection.

TDO

JTAG test data out programming and debug port connection.

Note

12. GPIOs with opamp outputs are not recommended for use with CapSense.

TMS

JTAG test mode select programming and debug port connection.

USBIO, D+

Provides D+ connection directly to a USB 2.0 bus. May be used as a digital I/O pin; it is powered from V_{DDP} instead of from a V_{DDIO} . Pins are Do Not Use (DNU) on devices without USB.

USBIO, D-

Provides D- connection directly to a USB 2.0 bus. May be used as a digital I/O pin; it is powered from V_{DDP} instead of from a V_{DDIO} . Pins are Do Not Use (DNU) on devices without USB.

Vboost

Power sense connection to boost pump.

Vbat

Battery supply to boost pump.

Vcca

Output of analog core regulator and input to analog core. Requires a 1- μ F capacitor to V_{SSA} . Regulator output not for external use.

Vccd

Output of digital core regulator and input to digital core. The two V_{CCD} pins must be shorted together, with the trace between them as short as possible, and a 1- μ F capacitor to V_{SSD} ; see [Power System](#) on page 24. Regulator output not for external use.

Vdda

Supply for all analog peripherals and analog core regulator. **Vdda must be the highest voltage present on the device. All other supply pins must be less than or equal to Vdda.**

Vddd

Supply for all digital peripherals and digital core regulator. V_{DDD} must be less than or equal to V_{DDA} .

Vssa

Ground for all analog peripherals.

Vssb

Ground connection for boost pump.

Vssd

Ground for all digital logic and I/O pins.

Vddio0, Vddio1, Vddio2, Vddio3

Supply for I/O pins. Each V_{DDIO} must be tied to a valid operating voltage (1.71 V to 5.5 V), and must be less than or equal to V_{DDA} . If the I/O pins associated with V_{DDIO0} , V_{DDIO2} , or V_{DDIO3} are not used then that V_{DDIO} should be tied to ground (V_{SSD} or V_{SSA}).

XRES (and configurable XRES)

External reset pin. Active low with internal pull-up. In 48-pin SSOP parts and 48-pin QFN parts, P1[2] may be configured as XRES. In all other parts the pin is configured as a GPIO.

4. CPU

4.1 8051 CPU

The CY8C38 devices use a single cycle 8051 CPU, which is fully compatible with the original MCS-51 instruction set. The CY8C38 family uses a pipelined RISC architecture, which executes most instructions in 1 to 2 cycles to provide peak performance of up to 33 MIPS with an average of 2 cycles per instruction. The single cycle 8051 CPU runs ten times faster than a standard 8051 processor.

The 8051 CPU subsystem includes these features:

- Single cycle 8051 CPU
- Up to 64 KB of flash memory, up to 2 KB of EEPROM, and up to 8 KB of SRAM
- Programmable nested vector interrupt controller
- DMA controller
- Peripheral HUB (PHUB)
- External memory interface (EMIF)

4.2 Addressing Modes

The following addressing modes are supported by the 8051:

- Direct Addressing: The operand is specified by a direct 8-bit address field. Only the internal RAM and the SFRs can be accessed using this mode.
- Indirect Addressing: The instruction specifies the register which contains the address of the operand. The registers R0 or R1 are used to specify the 8-bit address, while the data pointer (DPTR) register is used to specify the 16-bit address.
- Register Addressing: Certain instructions access one of the registers (R0 to R7) in the specified register bank. These instructions are more efficient because there is no need for an address field.
- Register Specific Instructions: Some instructions are specific to certain registers. For example, some instructions always act on the accumulator. In this case, there is no need to specify the operand.
- Immediate Constants: Some instructions carry the value of the constants directly instead of an address.
- Indexed Addressing: This type of addressing can be used only for a read of the program memory. This mode uses the Data Pointer as the base and the accumulator value as an offset to read a program memory.
- Bit Addressing: In this mode, the operand is one of 256 bits.

4.3 Instruction Set

The 8051 instruction set is highly optimized for 8-bit handling and Boolean operations. The types of instructions supported include:

- Arithmetic instructions
- Logical instructions
- Data transfer instructions
- Boolean instructions
- Program branching instructions

5. Memory

5.1 Static RAM

CY8C38 SRAM is used for temporary data storage. Up to 8 KB of SRAM is provided and can be accessed by the 8051 or the DMA controller. See [Memory Map](#) on page 19. Simultaneous access of SRAM by the 8051 and the DMA controller is possible if different 4-KB blocks are accessed.

5.2 Flash Program Memory

Flash memory in PSoC devices provides nonvolatile storage for user firmware, user configuration data, bulk data storage, and optional ECC data. The main flash memory area contains up to 64 KB of user program space.

Up to an additional 8 KB of flash space is available for ECC. If ECC is not used this space can store device configuration data and bulk user data. User code may not be run out of the ECC flash memory section. ECC can correct one bit error and detect two bit errors per 8 bytes of firmware memory; an interrupt can be generated when an error is detected.

Flash is read in units of rows; each row is 9 bytes wide with 8 bytes of data and 1 byte of ECC data. When a row is read, the data bytes are copied into an 8-byte instruction buffer. The CPU fetches its instructions from this buffer, for improved CPU performance.

Flash programming is performed through a special interface and preempts code execution out of flash. The flash programming interface performs flash erasing, programming and setting code protection levels. Flash in-system serial programming (ISSP), typically used for production programming, is possible through both the SWD and JTAG interfaces. In-system programming, typically used for bootloaders, is also possible using serial interfaces such as I²C, USB, UART, and SPI, or any communications protocol.

5.3 Flash Security

All PSoC devices include a flexible flash-protection model that prevents access and visibility to on-chip flash memory. This prevents duplication or reverse engineering of proprietary code. Flash memory is organized in blocks, where each block contains 256 bytes of program or data and 32 bytes of ECC or configuration data. A total of up to 256 blocks is provided on 64-KB flash devices.

The device offers the ability to assign one of four protection levels to each row of flash. [Table 5-1](#) lists the protection modes available. Flash protection levels can only be changed by performing a complete flash erase. The Full Protection and Field Upgrade settings disable external access (through a debugging tool such as PSoC Creator, for example). If your application requires code update through a bootloader, then use the Field Upgrade setting. Use the Unprotected setting only when no security is needed in your application. The PSoC device also offers an advanced security feature called Device Security which permanently disables all test, programming, and debug ports, protecting your application from external access (see the [“Device Security”](#) section on page 57). For more information about how to take full advantage of the security features in PSoC, see the [PSoC 3 TRM](#).

Table 5-1. Flash Protection

| Protection Setting | Allowed | Not Allowed |
|--------------------|---|--|
| Unprotected | External read and write + internal read and write | – |
| Factory Upgrade | External write + internal read and write | External read |
| Field Upgrade | Internal read and write | External read and write |
| Full Protection | Internal read | External read and write + internal write |

Disclaimer

Note the following details of the flash code protection features on Cypress devices.

Cypress products meet the specifications contained in their particular Cypress datasheets. Cypress believes that its family of products is one of the most secure families of its kind on the market today, regardless of how they are used. There may be methods, unknown to Cypress, that can breach the code protection features. Any of these methods, to our knowledge, would be dishonest and possibly illegal. Neither Cypress nor any other semiconductor manufacturer can guarantee the security of their code. Code protection does not mean that we are guaranteeing the product as ‘unbreakable’. Cypress is willing to work with the customer who is concerned about the integrity of their code. Code protection is constantly evolving. We at Cypress are committed to continuously improving the code protection features of our products.

5.4 EEPROM

PSoC EEPROM memory is a byte-addressable nonvolatile memory. The CY8C38 has up to 2 KB of EEPROM memory to store user data. Reads from EEPROM are random access at the byte level. Reads are done directly; writes are done by sending write commands to an EEPROM programming interface. CPU code execution can continue from flash during EEPROM writes. EEPROM is erasable and writeable at the row level. The EEPROM is divided into 128 rows of 16 bytes each. The CPU can not execute out of EEPROM. There is no ECC hardware associated with EEPROM. If ECC is required it must be handled in firmware.

5.5 External Memory Interface

CY8C38 provides an EMIF for connecting to external memory devices. The connection allows read and write accesses to external memories. The EMIF operates in conjunction with UDBs, I/O ports, and other hardware to generate external memory address and control signals. At 33 MHz, each memory access cycle takes four bus clock cycles. [Figure 5-1](#) is the EMIF block diagram. The EMIF supports synchronous and asynchronous memories. The CY8C38 supports only one type of external memory device at a time. External memory can be accessed through the 8051 xdata space; up to 24 address bits can be used. See [“xdata Space”](#) section on page 21. The memory can be 8 or 16 bits wide.

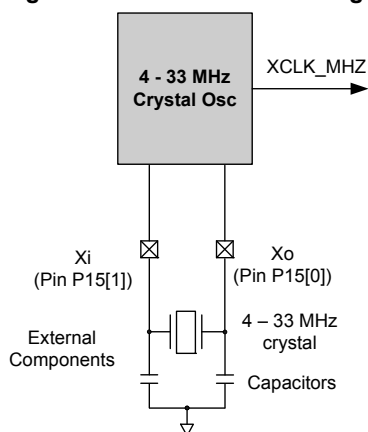
The 33-kHz clock (CLK33K) comes from a divide-by-3 operation on CLK100K. This output can be used as a reduced accuracy version of the 32.768-kHz ECO clock with no need for a crystal.

6.1.2 External Oscillators

6.1.2.1 MHz External Crystal Oscillator

The MHzECO provides high frequency, high precision clocking using an external crystal (see Figure 6-2). It supports a wide variety of crystal types, in the range of 4 to 33 MHz. When used in conjunction with the PLL, it can generate CPU and system clocks up to the device's maximum frequency (see PLL). The GPIO pins connecting to the external crystal and capacitors are fixed. MHzECO accuracy depends on the crystal chosen.

Figure 6-2. MHzECO Block Diagram

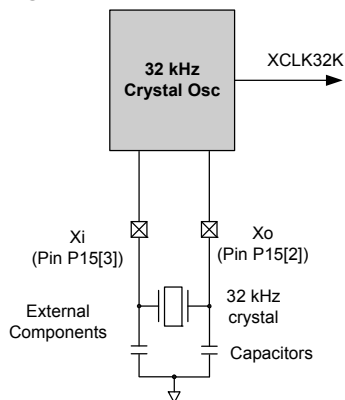


6.1.2.2 32.768-kHz ECO

The 32.768-kHz external crystal oscillator (32kHzECO) provides precision timing with minimal power consumption using an external 32.768-kHz watch crystal (see Figure 6-3). The 32kHzECO also connects directly to the sleep timer and provides the source for the RTC. The RTC uses a 1-second interrupt to implement the RTC functionality in firmware.

The oscillator works in two distinct power modes. This allows users to trade off power consumption with noise immunity from neighboring circuits. The GPIO pins connected to the external crystal and capacitors are fixed.

Figure 6-3. 32kHzECO Block Diagram



6.1.2.3 Digital System Interconnect

The DSI provides routing for clocks taken from external clock oscillators connected to I/O. The oscillators can also be generated within the device in the digital system and UDBs.

While the primary DSI clock input provides access to all clocking resources, up to eight other DSI clocks (internally or externally generated) may be routed directly to the eight digital clock dividers. This is only possible if there are multiple precision clock sources.

6.1.3 Clock Distribution

All seven clock sources are inputs to the central clock distribution system. The distribution system is designed to create multiple high precision clocks. These clocks are customized for the design's requirements and eliminate the common problems found with limited resolution prescalers attached to peripherals. The clock distribution system generates several types of clock trees.

- The system clock is used to select and supply the fastest clock in the system for general system clock requirements and clock synchronization of the PSoC device.
- Bus clock 16-bit divider uses the system clock to generate the system's bus clock used for data transfers. Bus clock is the source clock for the CPU clock divider.
- Eight fully programmable 16-bit clock dividers generate digital system clocks for general use in the digital system, as configured by the design's requirements. Digital system clocks can generate custom clocks derived from any of the seven clock sources for any purpose. Examples include baud rate generators, accurate PWM periods, and timer clocks, and many others. If more than eight digital clock dividers are required, the UDBs and fixed function timer/counter/PWMs can also generate clocks.
- Four 16-bit clock dividers generate clocks for the analog system components that require clocking, such as ADC and mixers. The analog clock dividers include skew control to ensure that critical analog events do not occur simultaneously with digital switching events. This is done to reduce analog system noise.

Each clock divider consists of an 8-input multiplexer, a 16-bit clock divider (divide by 2 and higher) that generates ~50 percent duty cycle clocks, system clock resynchronization logic, and deglitch logic. The outputs from each digital clock tree can be routed into the digital system interconnect and then brought back into the clock system as an input, allowing clock chaining of up to 32 bits.

6.1.4 USB Clock Domain

The USB clock domain is unique in that it operates largely asynchronously from the main clock network. The USB logic contains a synchronous bus interface to the chip, while running on an asynchronous clock to process USB data. The USB logic requires a 48 MHz frequency. This frequency can be generated from different sources, including DSI clock at 48 MHz or doubled value of 24 MHz from internal oscillator, DSI signal, or crystal oscillator.

6.2.1 Power Modes

PSoC 3 devices have four different power modes, as shown in [Table 6-2](#) and [Table 6-3](#). The power modes allow a design to easily provide required functionality and processing power while simultaneously minimizing power consumption and maximizing battery life in low-power and portable devices.

PSoC 3 power modes, in order of decreasing power consumption are:

- Active
- Alternate Active
- Sleep
- Hibernate

Active is the main processing mode. Its functionality is configurable. Each power controllable subsystem is enabled or disabled by using separate power configuration template registers. In alternate active mode, fewer subsystems are enabled, reducing power. In sleep mode most resources are disabled regardless of the template settings. Sleep mode is optimized to provide timed sleep intervals and Real Time Clock functionality. The lowest power mode is hibernate, which retains register and SRAM state, but no clocks, and allows wakeup only from I/O pins. [Figure 6-5](#) on page 26 illustrates the allowable transitions between power modes

Table 6-2. Power Modes

| Power Modes | Description | Entry Condition | Wakeup Source | Active Clocks | Regulator |
|------------------|---|--------------------------------------|---|--------------------|---|
| Active | Primary mode of operation, all peripherals available (programmable) | Wakeup, reset, manual register entry | Any interrupt | Any (programmable) | All regulators available. Digital and analog regulators can be disabled if external regulation used. |
| Alternate Active | Similar to Active mode, and is typically configured to have fewer peripherals active to reduce power. One possible configuration is to use the UDBs for processing, with the CPU turned off | Manual register entry | Any interrupt | Any (programmable) | All regulators available. Digital and analog regulators can be disabled if external regulation used. |
| Sleep | All subsystems automatically disabled | Manual register entry | Comparator, PICU, I ² C, RTC, CTW, LVD | ILO/kHzECO | Both digital and analog regulators buzzed. Digital and analog regulators can be disabled if external regulation used. |
| Hibernate | All subsystems automatically disabled Lowest power consuming mode with all peripherals and internal regulators disabled, except hibernate regulator is enabled Configuration and memory contents retained | Manual register entry | PICU | | Only hibernate regulator active. |

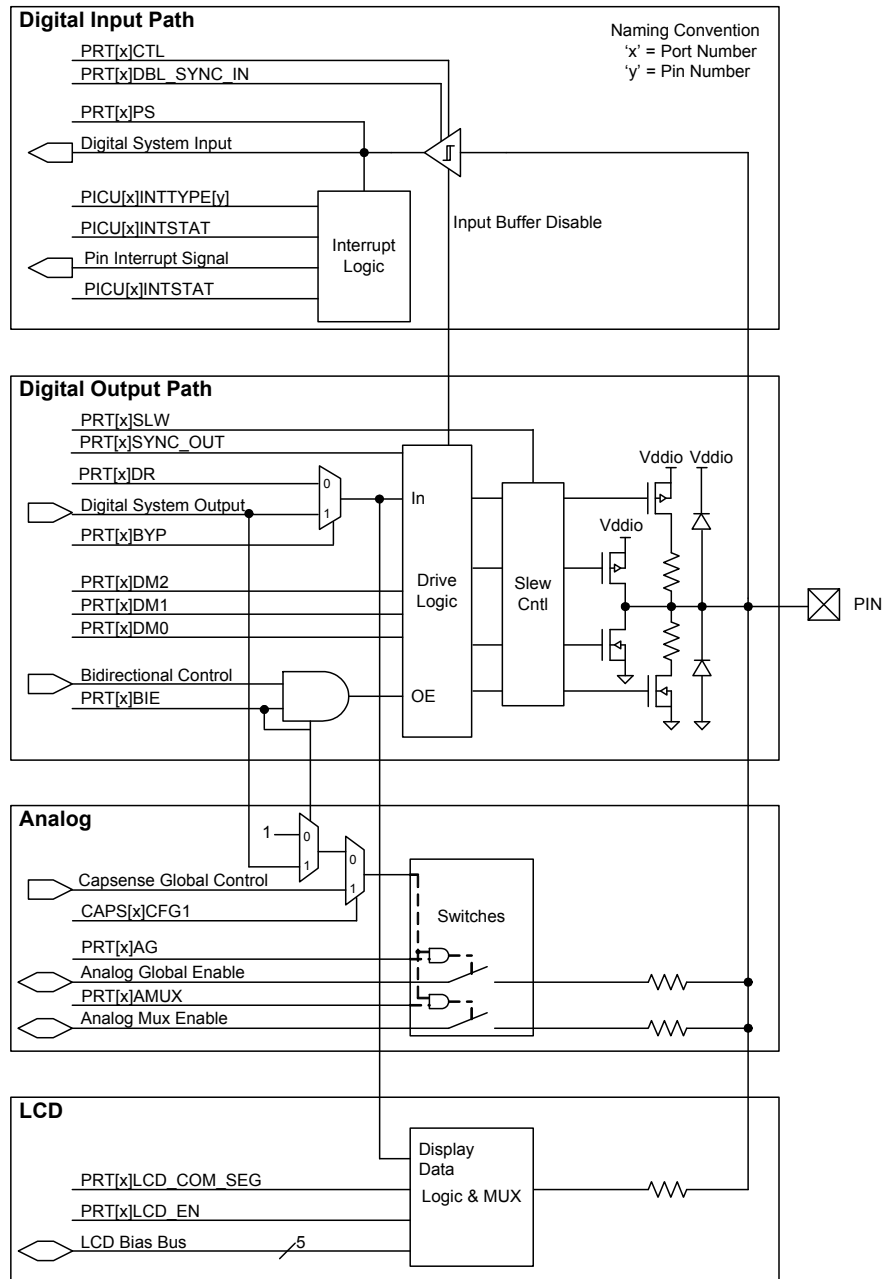
Table 6-3. Power Modes Wakeup Time and Power Consumption

| Sleep Modes | Wakeup Time | Current (typ) | Code Execution | Digital Resources | Analog Resources | Clock Sources Available | Wakeup Sources | Reset Sources |
|------------------|-------------|------------------------|----------------|-------------------|------------------|-------------------------|---|----------------|
| Active | – | 1.2 mA ^[13] | Yes | All | All | All | – | All |
| Alternate Active | – | – | User defined | All | All | All | – | All |
| Sleep | <15 µs | 1 µA | No | I ² C | Comparator | ILO/kHzECO | Comparator, PICU, I ² C, RTC, CTW, LVD | XRES, LVD, WDR |
| Hibernate | <100 µs | 200 nA | No | None | None | None | PICU | XRES |

Note

13. Bus clock off. Execute from CPU instruction buffer at 6 MHz. See [Table 11-2](#) on page 60.

Figure 6-8. GPIO Block Diagram



6.4.1 Drive Modes

Each GPIO and SIO pin is individually configurable into one of the eight drive modes listed in Table 6-6. Three configuration bits are used for each pin (DM[2:0]) and set in the PRTxDM[2:0] registers. Figure 6-11 depicts a simplified pin view based on each of the eight drive modes. Table 6-6 shows the I/O pin's drive state based on the port data register value or digital array signal if bypass mode is selected. Note that the actual I/O pin voltage is determined by a combination of the selected drive mode and the load at the pin. For example, if a GPIO pin is configured for resistive pull-up mode and driven high while the pin is floating, the voltage measured at the pin is a high logic state. If the same GPIO pin is externally tied to ground then the voltage unmeasured at the pin is a low logic state.

Figure 6-11. Drive Mode

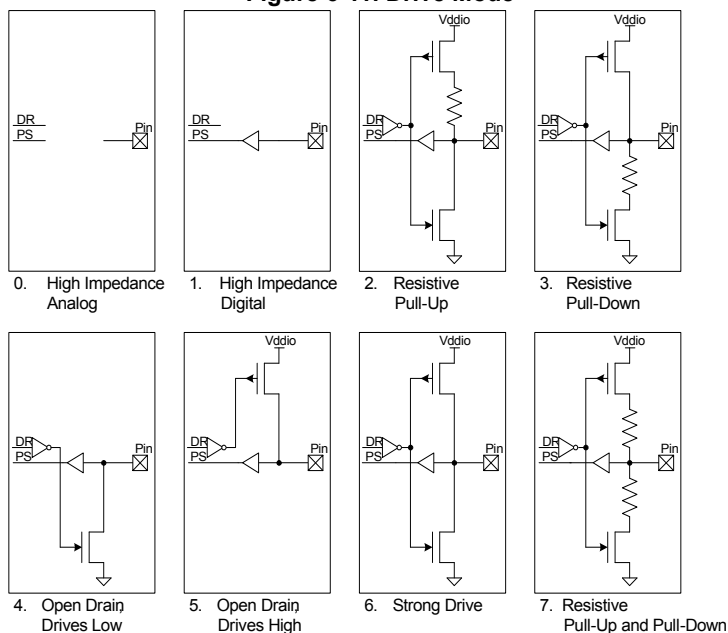


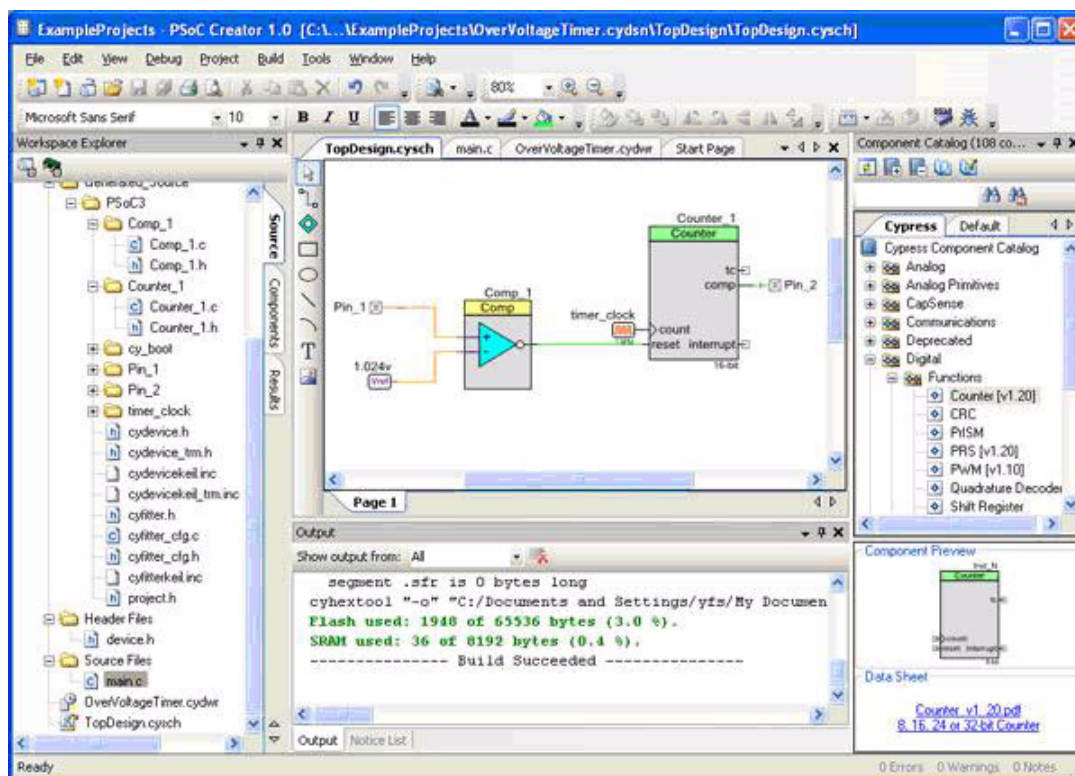
Table 6-6. Drive Modes

| Diagram | Drive Mode | PRTxDM2 | PRTxDM1 | PRTxDM0 | PRTxDR = 1 | PRTxDR = 0 |
|---------|---|---------|---------|---------|---------------|--------------|
| 0 | High impedance analog | 0 | 0 | 0 | High Z | High Z |
| 1 | High Impedance digital | 0 | 0 | 1 | High Z | High Z |
| 2 | Resistive pull-up ^[15] | 0 | 1 | 0 | Res High (5K) | Strong Low |
| 3 | Resistive pull-down ^[15] | 0 | 1 | 1 | Strong High | Res Low (5K) |
| 4 | Open drain, drives low | 1 | 0 | 0 | High Z | Strong Low |
| 5 | Open drain, drive high | 1 | 0 | 1 | Strong High | High Z |
| 6 | Strong drive | 1 | 1 | 0 | Strong High | Strong Low |
| 7 | Resistive pull-up and pull-down ^[15] | 1 | 1 | 1 | Res High (5K) | Res Low (5K) |

Note

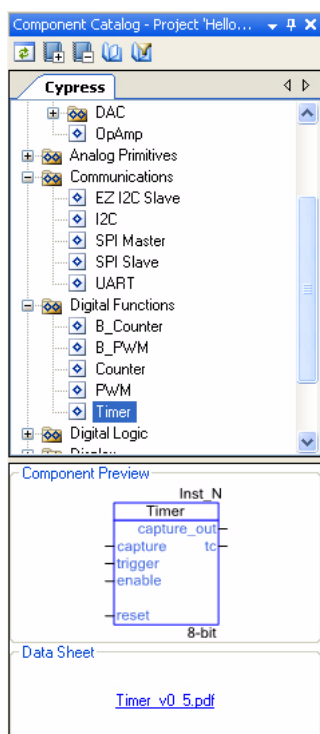
¹⁵ Resistive pull-up and pull-down are not available with SIO in regulated output mode.

Figure 7-2. PSoC Creator Framework



7.1.4.2 Component Catalog

Figure 7-3. Component Catalog

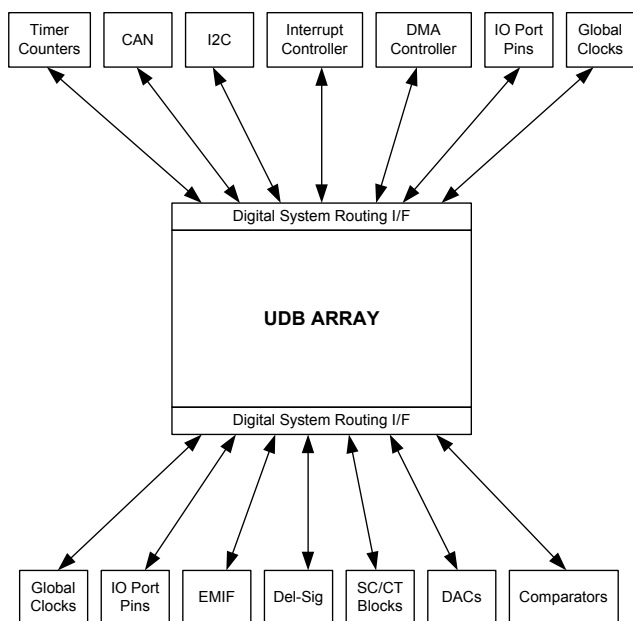


The component catalog is a repository of reusable design elements that select device functionality and customize your PSoC device. It is populated with an impressive selection of content; from simple primitives such as logic gates and device registers, through the digital timers, counters and PWMs, plus analog components such as ADC, DACs, and filters, and communication protocols, such as I²C, USB, and CAN. See [Example Peripherals](#) on page 35 for more details about available peripherals. All content is fully characterized and carefully documented in datasheets with code examples, AC/DC specifications, and user code ready APIs.

7.1.4.3 Design Reuse

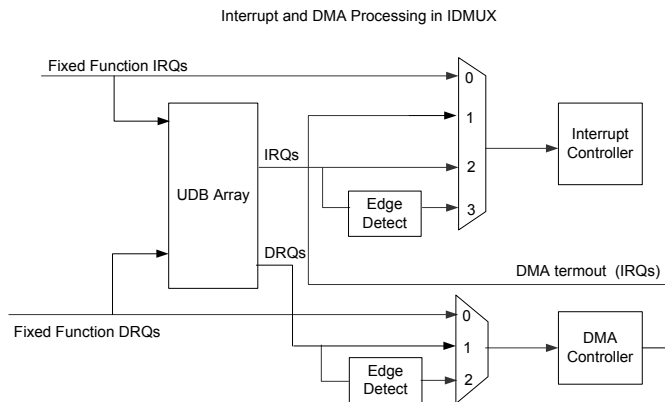
The symbol editor gives you the ability to develop reusable components that can significantly reduce future design time. Just draw a symbol and associate that symbol with your proven design. PSoC Creator allows for the placement of the new symbol anywhere in the component catalog along with the content provided by Cypress. You can then reuse your content as many times as you want, and in any number of projects, without ever having to revisit the details of the implementation.

Figure 7-13. Digital System Interconnect



Interrupt and DMA routing is very flexible in the CY8C38 programmable architecture. In addition to the numerous fixed function peripherals that can generate interrupt requests, any data signal in the UDB array routing can also be used to generate a request. A single peripheral may generate multiple independent interrupt requests simplifying system and firmware design. Figure 7-14 shows the structure of the IDMUX (Interrupt/DMA Multiplexer).

Figure 7-14. Interrupt and DMA Processing in the IDMUX



7.4.1 I/O Port Routing

There are a total of 20 DSI routes to a typical 8-bit I/O port, 16 for data and four for drive strength control.

When an I/O pin is connected to the routing, there are two primary connections available, an input and an output. In conjunction with drive strength control, this can implement a bidirectional I/O pin. A data output signal has the option to be

single synchronized (pipelined) and a data input signal has the option to be double synchronized. The synchronization clock is the system clock (see Figure 6-1). Normally all inputs from pins are synchronized as this is required if the CPU interacts with the signal or any signal derived from it. Asynchronous inputs have rare uses. An example of this is a feed through of combinational PLD logic from input pins to output pins.

Figure 7-15. I/O Pin Synchronization Routing

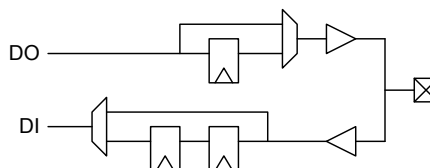
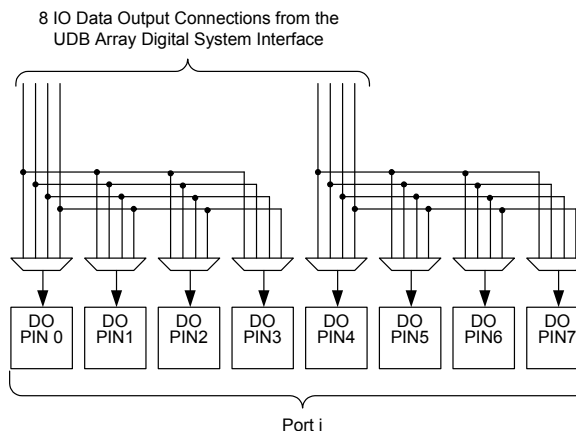
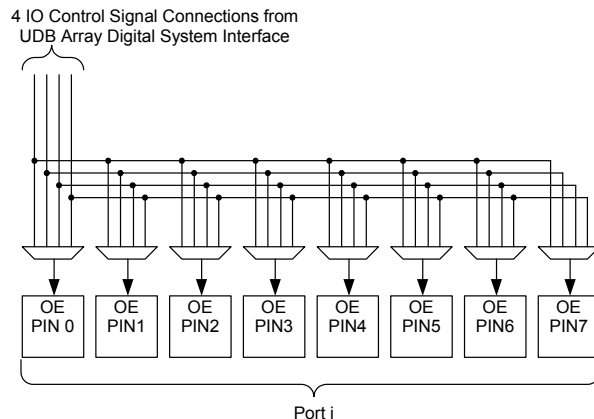


Figure 7-16. I/O Pin Output Connectivity



There are four more DSI connections to a given I/O port to implement dynamic output enable control of pins. This connectivity gives a range of options, from fully ganged 8-bits controlled by one signal, to up to four individually controlled pins. The output enable signal is useful for creating tri-state bidirectional pins and buses.

Figure 7-17. I/O Pin Output Enable Connectivity



Analog local buses (abus) are routing resources located within the analog subsystem and are used to route signals between different analog blocks. There are eight abus routes in CY8C38, four in the left half (abusl [0:3]) and four in the right half (abusr [0:3]) as shown in Figure 8-2. Using the abus saves the analog globals and analog mux buses from being used for interconnecting the analog blocks.

Multiplexers and switches exist on the various buses to direct signals into and out of the analog blocks. A multiplexer can have only one connection on at a time, whereas a switch can have multiple connections on simultaneously. In Figure 8-2, multiplexers are indicated by grayed ovals and switches are indicated by transparent ovals.

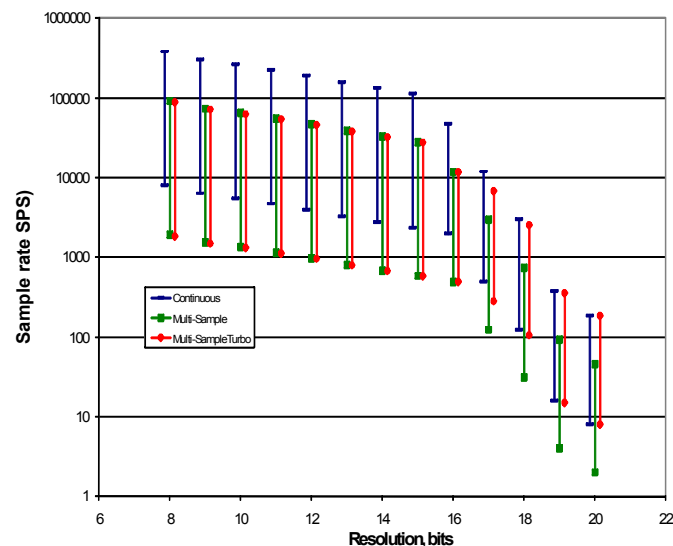
8.2 Delta-sigma ADC

The CY8C38 device contains one delta-sigma ADC. This ADC offers differential input, high resolution and excellent linearity, making it a good ADC choice for both audio signal processing and measurement applications. The converter's nominal operation is 16 bits at 48 ksp/s. The ADC can be configured to output 20-bit resolution at data rates of up to 187 sps. At a fixed clock rate, resolution can be traded for faster data rates as shown in Table 8-1 and Figure 8-3.

Table 8-1. Delta-sigma ADC Performance

| Bits | Maximum Sample Rate (sps) | SINAD (dB) |
|------|---------------------------|------------|
| 20 | 187 | — |
| 16 | 48 k | 84 |
| 12 | 192 k | 66 |
| 8 | 384 k | 43 |

Figure 8-3. Delta-sigma ADC Sample Rates, Range = ± 1.024 V



8.2.1 Functional Description

The ADC connects and configures three basic components, input buffer, delta-sigma modulator, and decimator. The basic block diagram is shown in Figure 8-4. The signal from the input muxes is delivered to the delta-sigma modulator either directly or through the input buffer. The delta-sigma modulator performs the actual analog to digital conversion. The modulator over-samples the input and generates a serial data stream output. This high speed data stream is not useful for most applications without some type of post processing, and so is passed to the decimator through the Analog Interface block. The decimator converts the high speed serial data stream into parallel ADC results. The modulator/decimator frequency response is $[(\sin x)/x]^4$; a typical frequency response is shown in Figure 8-5.

Figure 8-4. Delta-sigma ADC Block Diagram

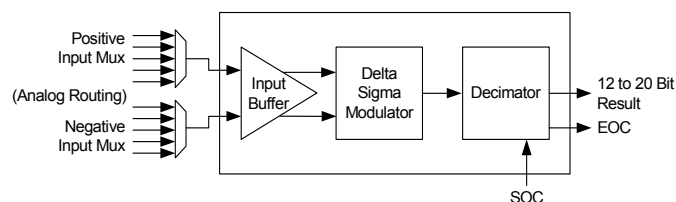
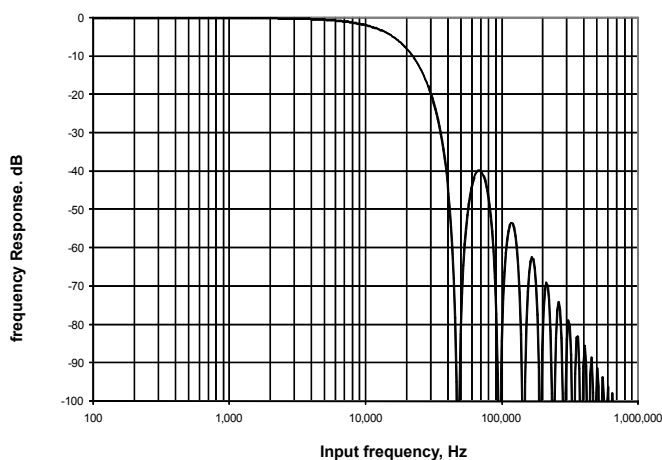


Figure 8-5. Delta-sigma ADC Frequency Response, Normalized to Output, Sample Rate = 48 kHz

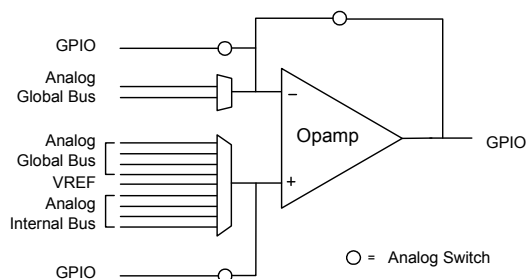


Resolution and sample rate are controlled by the Decimator. Data is pipelined in the decimator; the output is a function of the last four samples. When the input multiplexer is switched, the output data is not valid until after the fourth sample after the switch.

8.2.2 Operational Modes

The ADC can be configured by the user to operate in one of four modes: Single Sample, Multi Sample, Continuous, or Multi Sample (Turbo). All four modes are started by either a write to the start bit in a control register or an assertion of the Start of Conversion (SoC) signal. When the conversion is complete, a status bit is set and the output signal End of Conversion (EoC)

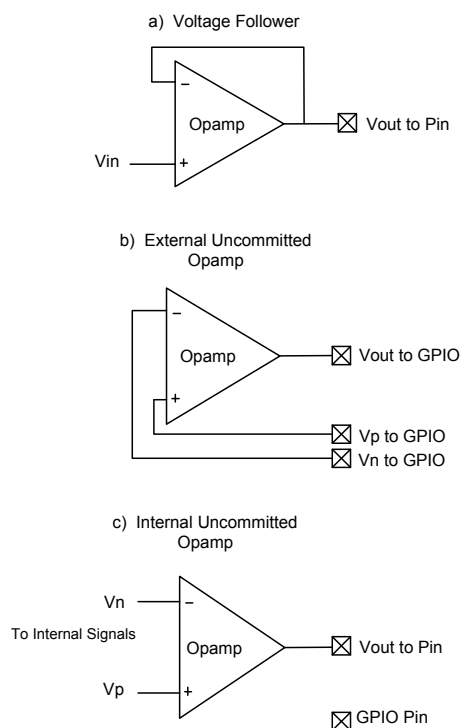
Figure 8-7. Opamp



The opamp is uncommitted and can be configured as a gain stage or voltage follower, or output buffer on external or internal signals.

See Figure 8-8. In any configuration, the input and output signals can all be connected to the internal global signals and monitored with an ADC, or comparator. The configurations are implemented with switches between the signals and GPIO pins.

Figure 8-8. Opamp Configurations



The opamp has three speed modes, slow, medium, and fast. The slow mode consumes the least amount of quiescent power and the fast mode consumes the most power. The inputs are able to swing rail-to-rail. The output swing is capable of rail-to-rail operation at low current output, within 50 mV of the rails. When driving high current loads (about 25 mA) the output voltage may only get within 500 mV of the rails.

8.5 Programmable SC/CT Blocks

The CY8C38 family of devices contains up to four switched capacitor/continuous time (SC/CT) blocks in a device. Each switched capacitor/continuous time block is built around a single rail-to-rail high bandwidth opamp.

Switched capacitor is a circuit design technique that uses capacitors plus switches instead of resistors to create analog functions. These circuits work by moving charge between capacitors by opening and closing different switches. Nonoverlapping in phase clock signals control the switches, so that not all switches are ON simultaneously.

The PSoC Creator tool offers a user friendly interface, which allows you to easily program the SC/CT blocks. Switch control and clock phase control configuration is done by PSoC Creator so users only need to determine the application use parameters such as gain, amplifier polarity, V_{REF} connection, and so on.

The same opamps and block interfaces are also connectable to an array of resistors which allows the construction of a variety of continuous time functions.

The opamp and resistor array is programmable to perform various analog functions including

- Naked operational amplifier – Continuous mode
- Unity-gain buffer – Continuous mode
- PGA – Continuous mode
- Transimpedance amplifier (TIA) – Continuous mode
- Up/down mixer – Continuous mode
- Sample and hold mixer (NRZ S/H) – Switched cap mode
- First order analog to digital modulator – Switched cap mode

8.5.1 Naked Opamp

The Naked Opamp presents both inputs and the output for connection to internal or external signals. The opamp has a unity gain bandwidth greater than 6.0 MHz and output drive current up to 650 μ A. This is sufficient for buffering internal signals (such as DAC outputs) and driving external loads greater than 7.5 kohms.

8.5.2 Unity Gain

The Unity Gain buffer is a Naked Opamp with the output directly connected to the inverting input for a gain of 1.00. It has a -3 dB bandwidth greater than 6.0 MHz.

8.5.3 PGA

The PGA amplifies an external or internal signal. The PGA can be configured to operate in inverting mode or noninverting mode. The PGA function may be configured for both positive and negative gains as high as 50 and 49 respectively. The gain is adjusted by changing the values of R1 and R2 as illustrated in Figure 8-9. The schematic in Figure 8-9 shows the configuration and possible resistor settings for the PGA. The gain is switched from inverting and non inverting by changing the shared select value of the both the input muxes. The bandwidth for each gain case is listed in Table 8-3.

11.4.2 SIO

Table 11-11. SIO DC Specifications

| Parameter | Description | Conditions | Min | Typ | Max | Units |
|-----------------|--|--|-----------------------|-----|------------------------|-------|
| Vinmax | Maximum input voltage | All allowed values of Vddio and Vddd, see Section 11.2.1 | – | – | 5.5 | V |
| Vinref | Input voltage reference (Differential input mode) | | 0.5 | – | $0.52 \times V_{DDIO}$ | V |
| Voutref | Output voltage reference (Regulated output mode) | | | | | |
| | | $V_{DDIO} > 3.7$ | 1 | – | $V_{DDIO} - 1$ | V |
| | | $V_{DDIO} < 3.7$ | 1 | – | $V_{DDIO} - 0.5$ | V |
| V _{IH} | Input voltage high threshold | | | | | |
| | GPIO mode | CMOS input | $0.7 \times V_{DDIO}$ | – | – | V |
| | Differential input mode ^[30] | Hysteresis disabled | SIO_ref + 0.2 | – | – | V |
| V _{IL} | Input voltage low threshold | | | | | |
| | GPIO mode | CMOS input | – | – | $0.3 \times V_{DDIO}$ | V |
| | Differential input mode ^[30] | Hysteresis disabled | – | – | SIO_ref – 0.2 | V |
| V _{OH} | Output voltage high | | | | | |
| | Unregulated mode | $I_{OH} = 4 \text{ mA}$, $V_{DDIO} = 3.3 \text{ V}$ | $V_{DDIO} - 0.4$ | – | – | V |
| | Regulated mode ^[30] | $I_{OH} = 1 \text{ mA}$ | SIO_ref – 0.65 | – | SIO_ref + 0.2 | V |
| | Regulated mode ^[30] | $I_{OH} = 0.1 \text{ mA}$ | SIO_ref – 0.3 | – | SIO_ref + 0.2 | V |
| V _{OL} | Output voltage low | | | | | |
| | | $V_{DDIO} = 3.30 \text{ V}$, $I_{OL} = 25 \text{ mA}$ | – | – | 0.8 | V |
| | | $V_{DDIO} = 1.80 \text{ V}$, $I_{OL} = 4 \text{ mA}$ | – | – | 0.4 | V |
| Rpullup | Pull-up resistor | | 3.5 | 5.6 | 8.5 | kΩ |
| Rpulldown | Pull-down resistor | | 3.5 | 5.6 | 8.5 | kΩ |
| I _{IL} | Input leakage current (Absolute value) ^[31] | | | | | |
| | $V_{IH} \leq V_{ddio}$ | 25 °C, $V_{ddio} = 3.0 \text{ V}$, $V_{IH} = 3.0 \text{ V}$ | – | – | 14 | nA |
| | $V_{IH} > V_{ddio}$ | 25 °C, $V_{ddio} = 0 \text{ V}$, $V_{IH} = 3.0 \text{ V}$ | – | – | 10 | μA |
| C _{IN} | Input Capacitance ^[31] | | – | – | 7 | pF |
| V _H | Input voltage hysteresis (Schmitt-Trigger) ^[31] | Single ended mode (GPIO mode) | – | 40 | – | mV |
| | | Differential mode | – | 35 | – | mV |
| Idiode | Current through protection diode to V _{SSIO} | | – | – | 100 | μA |

Table 11-12. SIO AC Specifications

| Parameter | Description | Conditions | Min | Typ | Max | Units |
|-----------|--|--|-----|-----|-----|-------|
| TriseF | Rise time in fast strong mode (90/10%) ^[31] | Clod = 25 pF, $V_{DDIO} = 3.3 \text{ V}$ | – | – | 12 | ns |
| TfallF | Fall time in fast strong mode (90/10%) ^[31] | Clod = 25 pF, $V_{DDIO} = 3.3 \text{ V}$ | – | – | 12 | ns |
| TriseS | Rise time in slow strong mode (90/10%) ^[31] | Clod = 25 pF, $V_{DDIO} = 3.0 \text{ V}$ | – | – | 75 | ns |
| TfallS | Fall time in slow strong mode (90/10%) ^[31] | Clod = 25 pF, $V_{DDIO} = 3.0 \text{ V}$ | – | – | 60 | ns |

Notes

30. See Figure 6-9 on page 30 and Figure 6-12 on page 33 for more information on SIO reference.

31. Based on device characterization (Not production tested).

11.5 Analog Peripherals

Specifications are valid for $-40^{\circ}\text{C} \leq T_A \leq 85^{\circ}\text{C}$ and $T_J \leq 100^{\circ}\text{C}$, except where noted. Specifications are valid for 1.71 V to 5.5 V, except where noted.

11.5.1 Opamp

Table 11-18. Opamp DC Specifications

| Parameter | Description | Conditions | Min | Typ | Max | Units |
|------------|---|---|------------------|----------|------------------|--------------------------------|
| V_i | Input voltage range | | V_{SSA} | – | V_{DDA} | V |
| V_{os} | Input offset voltage | | – | – | 2.5 | mV |
| | | Operating temperature -40°C to 70°C | – | – | 2 | mV |
| TCV_{os} | Input offset voltage drift with temperature | Power mode = high | – | ± 12 | – | $\mu\text{V}/^{\circ}\text{C}$ |
| Ge_1 | Gain error, unity gain buffer mode | $R_{load} = 1\text{ k}\Omega$ | – | – | ± 0.1 | % |
| C_{in} | Input capacitance | Routing from pin | – | – | 18 | pF |
| V_o | Output voltage range | 1 mA, source or sink, power mode = high | $V_{SSA} + 0.05$ | – | $V_{DDA} - 0.05$ | V |
| I_{out} | Output current, source or sink | $V_{SSA} + 500\text{ mV} \leq V_{out} \leq V_{DDA}$ $-500\text{ mV}, V_{DDA} > 2.7\text{ V}$ | 25 | – | – | mA |
| | | $V_{SSA} + 500\text{ mV} \leq V_{out} \leq V_{DDA}$ $-500\text{ mV}, 1.7\text{ V} = V_{DDA} \leq 2.7\text{ V}$ | 16 | – | – | mA |
| I_{dd} | Quiescent current | Power mode = min | – | 200 | 270 | μA |
| | | Power mode = low | – | 250 | 400 | μA |
| | | Power mode = med | – | 330 | 950 | μA |
| | | Power mode = high | – | 1000 | 2500 | μA |
| CMRR | Common mode rejection ratio | | 80 | – | – | dB |
| PSRR | Power supply rejection ratio | $V_{dda} \geq 2.7\text{ V}$ | 85 | – | – | dB |
| | | $V_{dda} < 2.7\text{ V}$ | 70 | – | – | dB |

Figure 11-2. Opamp Voffset Histogram, 60 samples / 15 parts, 25°C , $V_{dda} = 5\text{V}$

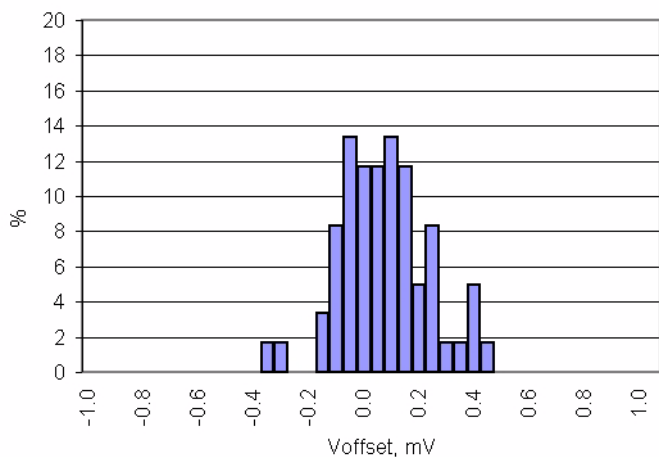


Figure 11-3. Opamp Voffset vs Temperature, $V_{dda} = 5\text{V}$

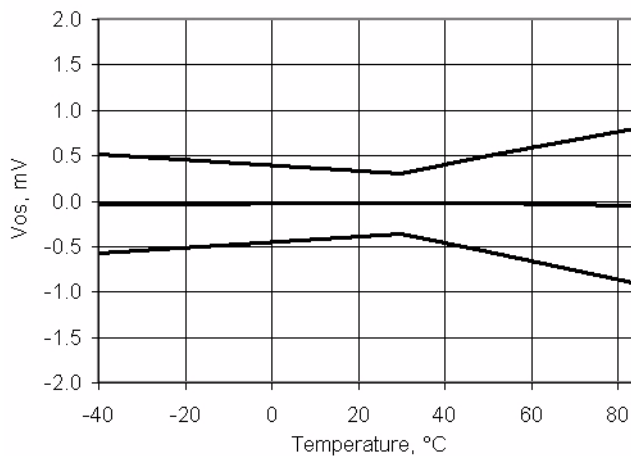


Table 11-19. Opamp AC Specifications

| Parameter | Description | Conditions | Min | Typ | Max | Units |
|----------------|------------------------|---|-----|-----|-----|-----------|
| GBW | Gain-bandwidth product | Power mode = minimum, 200 pF load | 1 | – | – | MHz |
| | | Power mode = low, 200 pF load | 2 | – | – | MHz |
| | | Power mode = medium, 200 pF load | 1 | – | – | MHz |
| | | Power mode = high, 200 pF load | 3 | – | – | MHz |
| SR | Slew rate, 20% - 80% | Power mode = low, 200 pF load | 1.1 | – | – | V/μs |
| | | Power mode = medium, 200 pF load | 0.9 | – | – | V/μs |
| | | Power mode = high, 200 pF load | 3 | – | – | V/μs |
| e _n | Input noise density | Power mode = high, V _{dda} = 5 V, at 100 kHz | – | 45 | – | nV/sqrtHz |

Figure 11-10. Open Loop Gain and Phase vs Frequency and Temperature, Power Mode = High, C_I = 15 Pf, V_{dda} = 5V

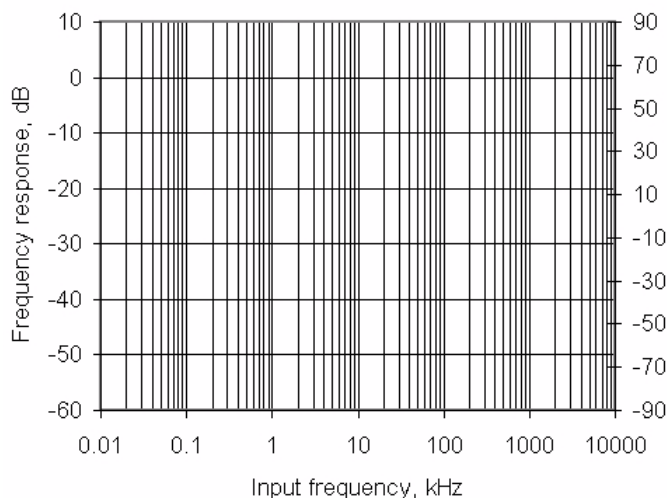


Figure 11-11. Opamp Closed Loop Frequency Response, Gain = 1, V_{dda} = 5V

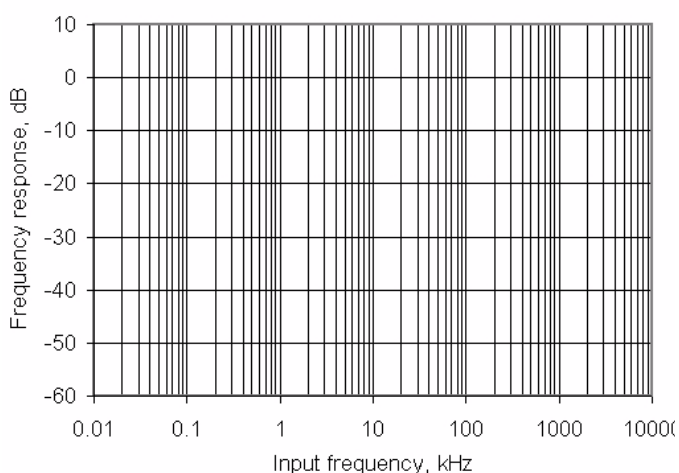


Figure 11-12. Opamp Closed Loop Frequency Response, Gain = 10, Vdda = 5V

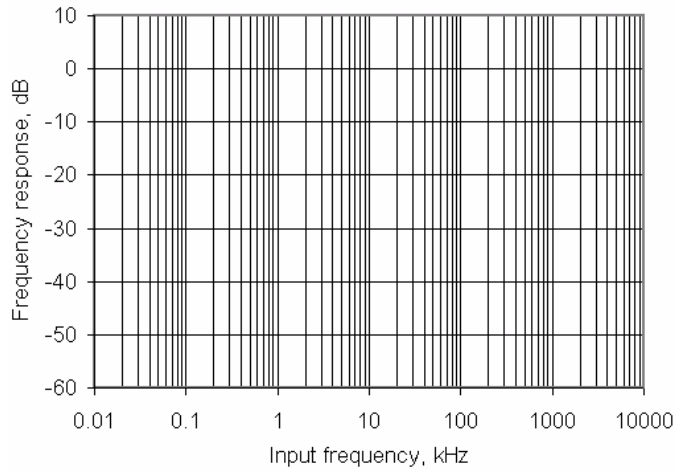


Figure 11-13. Opamp test Circuit for Gain = 10

Figure 11-14. Opamp Noise vs Frequency, Power Mode = High, Vdda = 5V

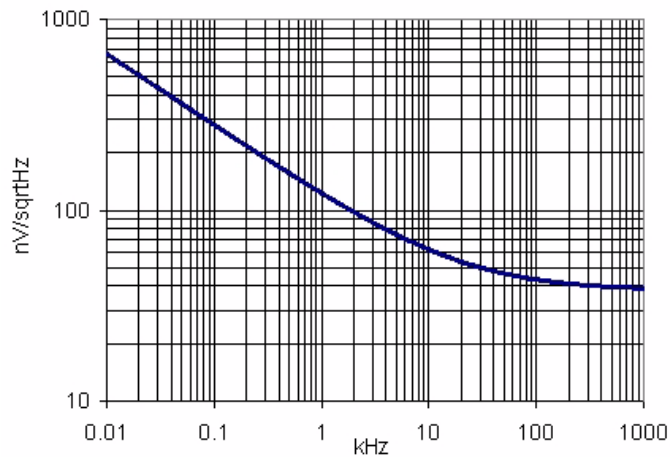


Figure 11-15. Opamp CMRR vs Frequency

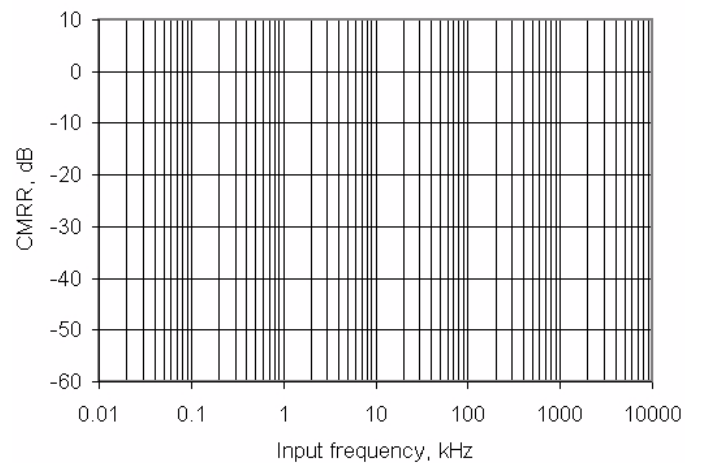
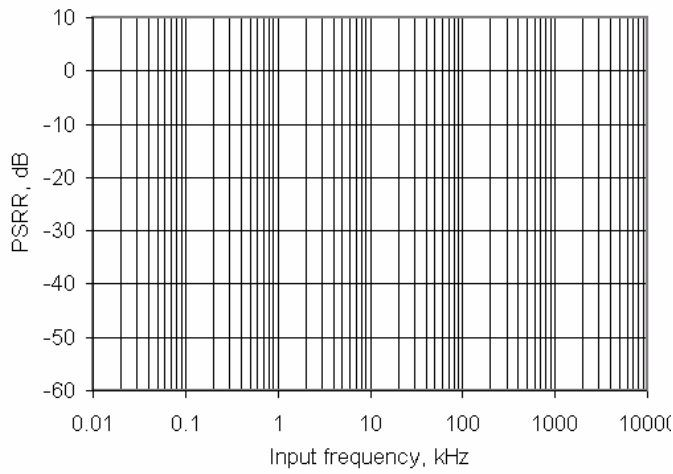


Figure 11-16. Opamp PSRR vs Frequency



11.9.6 Phase-Locked Loop

Table 11-83. PLL DC Specifications

| Parameter | Description | Conditions | Min | Typ | Max | Units |
|-----------------|-----------------------|--------------------------|-----|-----|-----|-------|
| I _{DD} | PLL operating current | In = 3 MHz, Out = 67 MHz | – | 400 | – | μA |
| | | In = 3 MHz, Out = 24 MHz | – | 200 | – | μA |

Table 11-84. PLL AC Specifications

| Parameter | Description | Conditions | Min | Typ | Max | Units |
|-------------------------|--|---------------------|-----|-----|-----|-------|
| F _{plin} | PLL input frequency ^[51] | | 1 | – | 48 | MHz |
| | PLL intermediate frequency ^[52] | Output of prescaler | 1 | – | 3 | MHz |
| F _{plout} | PLL output frequency ^[51] | | 24 | – | 67 | MHz |
| | Lock time at startup | | – | – | 250 | μs |
| J _{period-rms} | Jitter (rms) ^[53] | | – | – | 250 | ps |

Notes

51. This specification is guaranteed by testing the PLL across the specified range using the IMO as the source for the PLL.

52. PLL input divider, Q, must be set so that the input frequency is divided down to the intermediate frequency range. Value for Q ranges from 1 to 16.

53. Based on device characterization (Not production tested).

13. Packaging

Table 13-1. Package Characteristics

| Parameter | Description | Conditions | Min | Typ | Max | Units |
|-----------------|--|------------|-----|-------|-----|---------|
| T _A | Operating ambient temperature | | -40 | 25.00 | 85 | °C |
| T _J | Operating junction temperature | | -40 | – | 100 | °C |
| T _{ja} | Package θJA (48-pin SSOP) | | – | 45.16 | – | °C/Watt |
| T _{ja} | Package θJA (48-pin QFN) | | – | 15.94 | – | °C/Watt |
| T _{ja} | Package θJA (68-pin QFN) | | – | 11.72 | – | °C/Watt |
| T _{ja} | Package θJA (100-pin TQFP) | | – | 30.52 | – | °C/Watt |
| T _{jc} | Package θJC (48-pin SSOP) | | – | 27.84 | – | °C/Watt |
| T _{jc} | Package θJC (48-pin QFN) | | – | 7.05 | – | °C/Watt |
| T _{jc} | Package θJC (68-pin QFN) | | – | 6.32 | – | °C/Watt |
| T _{jc} | Package θJC (100-pin TQFP) | | – | 9.04 | – | °C/Watt |
| | Pb-free assemblies (20s to 40s) – Sn-Ag-Cu solder paste reflow temperature | | 235 | – | 245 | °C |
| | Pb-free assemblies (20s to 40s) – Sn-Pb solder paste reflow temperature | | 205 | – | 220 | °C |

Table 13-2. Package Moisture Sensitivity Level (MSL), IPC/JEDEC J-STD-2

| Package | MSL |
|--------------|-------|
| 48-pin SSOP | MSL 1 |
| 48-pin QFN | MSL 3 |
| 68-pin QFN | MSL 3 |
| 100-pin TQFP | MSL 3 |

Figure 13-1. 48-pin (300 mil) SSOP Package Outline

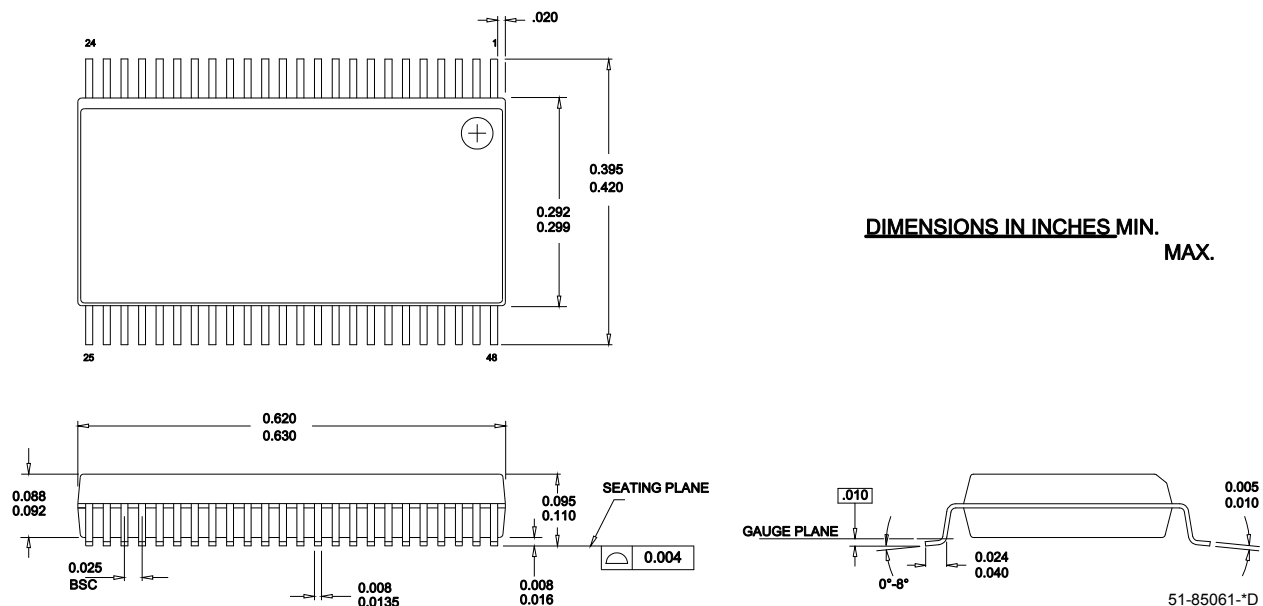


Table 14-1. Acronyms Used in this Document *(continued)*

| Acronym | Description |
|---------|--|
| PGA | programmable gain amplifier |
| PHUB | peripheral hub |
| PHY | physical layer |
| PICU | port interrupt control unit |
| PLA | programmable logic array |
| PLD | programmable logic device, see also PAL |
| PLL | phase-locked loop |
| PMDD | package material declaration datasheet |
| POR | power-on reset |
| PRES | precise power-on reset |
| PRS | pseudo random sequence |
| PS | port read data register |
| PSoC® | Programmable System-on-Chip™ |
| PSRR | power supply rejection ratio |
| PWM | pulse-width modulator |
| RAM | random-access memory |
| RISC | reduced-instruction-set computing |
| RMS | root-mean-square |
| RTC | real-time clock |
| RTL | register transfer language |
| RTR | remote transmission request |
| RX | receive |
| SAR | successive approximation register |
| SC/CT | switched capacitor/continuous time |
| SCL | I ² C serial clock |
| SDA | I ² C serial data |
| S/H | sample and hold |
| SINAD | signal to noise and distortion ratio |
| SIO | special input/output, GPIO with advanced features. See GPIO. |
| SOC | start of conversion |
| SOF | start of frame |
| SPI | Serial Peripheral Interface, a communications protocol |
| SR | slew rate |
| SRAM | static random access memory |
| SRES | software reset |
| SWD | serial wire debug, a test protocol |
| SWV | single-wire viewer |
| TD | transaction descriptor, see also DMA |

Table 14-1. Acronyms Used in this Document *(continued)*

| Acronym | Description |
|---------|--|
| THD | total harmonic distortion |
| TIA | transimpedance amplifier |
| TRM | technical reference manual |
| TTL | transistor-transistor logic |
| TX | transmit |
| UART | Universal Asynchronous Transmitter Receiver, a communications protocol |
| UDB | universal digital block |
| USB | Universal Serial Bus |
| USBIO | USB input/output, PSoC pins used to connect to a USB port |
| VDAC | voltage DAC, see also DAC, IDAC |
| WDT | watchdog timer |
| WOL | write once latch, see also NVL |
| WRES | watchdog timer reset |
| XRES | external reset I/O pin |
| XTAL | crystal |

15. Reference Documents

[PSoC® 3, PSoC® 5 Architecture TRM](#)

[PSoC® 3 Registers TRM](#)

16. Document Conventions

16.1 Units of Measure

Table 16-1. Units of Measure

| Symbol | Unit of Measure |
|--------|------------------------|
| °C | degrees Celsius |
| dB | decibels |
| fF | femtofarads |
| Hz | hertz |
| KB | 1024 bytes |
| kbps | kilobits per second |
| Khr | kilohours |
| kHz | kilohertz |
| kΩ | kilohms |
| ksps | kilosamples per second |
| LSB | least significant bit |
| Mbps | megabits per second |
| MHz | megahertz |
| MΩ | megaohms |
| Msp | megasamples per second |

| Description Title: PSoC® 3: CY8C38 Family Datasheet Programmable System-on-Chip (PSoC®) Document Number: 001-11729 | | | | |
|---|---------|------------|------|---|
| *Q | 3179219 | 02/22/2011 | MKEA | Updated conditions for flash data retention time Updated 100-pin TQFP package spec. Updated EEPROM AC specifications. |

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